

<b>Notice of References Cited</b>	Application/Control No. 10/785,479	Applicant(s)/Patent Under Reexamination GRUNBACHER ET AL.	
	Examiner Hien X. Vo	Art Unit 2863	Page 1 of 1

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	K	US-			
	L	US-			
	M	US-			

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	N	EP 1048943A2	11/2000	European	Nakanishi et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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